

Luminescence and Scintillation Properties of Eu-doped CaAl₂O₄ Bulk Crystals

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(Received November 30, 2018; accepted March 25, 2019)

Keywords: scintillator, dosimetry, photoluminescence, radioluminescence, crystal growth, afterglow

Eu-doped CaAl₂O₄ bulk crystals were synthesized by the floating zone (FZ) method, and their photoluminescence (PL) and scintillation properties were investigated firstly in a bulk crystal. The crystal samples exhibit PL and radioluminescence (RL) with a broad emission peaking around 440 nm as well as sharp peaks appearing around 600 nm, which are similarly observed for powder samples. Suggested from the decay time constants, they are attributed to the 5d–4f transitions of Eu²⁺ and the 4f–4f transitions of Eu³⁺, respectively. From the pulse height spectrum under ²⁴¹Am γ -ray (59.5 keV) exposure, the light yield (LY) of a 3.0% Eu:CaAl₂O₄ bulk crystal is approximately 12000 ph/MeV.

1. Introduction

Scintillators utilizing inorganic luminescent materials have a function to immediately convert ionizing radiation into low-energy photons, so they have been attracting considerable interest in response to increasing demands of radiation detection including medical imaging,⁽¹⁾ security,⁽²⁾ astrophysics,⁽³⁾ environmental monitoring,⁽⁴⁾ and resource exploration, e.g., oil-dwelling.⁽⁵⁾ In recent years, a divalent europium (Eu²⁺) center has attracted attention as a luminescent center of scintillators. Eu²⁺ shows the luminescence due to the spin- and parity-allowed 5d–4f transitions with a broad absorption and emission band in ultraviolet and visible regions.⁽⁶⁾ Since Eu²⁺ exhibits a relatively short decay time and a high emission efficiency, Eu²⁺-doped scintillators with a high sensitivity to various types of ionizing radiation have been developed.^(7–9) The luminescence of Eu²⁺, originating from the 4f⁷→4f⁶5d transition, strongly relies on the type of environment (e.g., crystal field) around Eu²⁺ ions. This means that the emission wavelength of a Eu-doped scintillator depends on the host material. Therefore, from an academic viewpoint, the investigation of new Eu-doped materials is very interesting.

Alkaline-earth aluminates have been our recent interest for scintillator applications.^(10–14) Over the past decades, Eu²⁺-doped alkaline-earth aluminates have been widely studied as phosphors with a bright luminescence in the visible wavelength range.^(15–17) In particular, Nd-Eu-codoped calcium dialuminate (CaAl₂O₄), which is discovered by Yamamoto and

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<https://doi.org/10.18494/SAM.2019.2184>

Matsuzawa,⁽¹⁸⁾ is known as the most famous blue persistent phosphor showing a long-lasting luminescence.^(19,20) However, in spite of the great luminescence properties,^(21,22) no study has been reported on the observation of radioluminescence (RL) from Eu:CaAl₂O₄ as far as we know. Previously, we showed that a Eu-doped SrAl₂O₄ bulk crystal, which belongs to the alkaline-earth aluminate group as well, exhibits a notably high scintillation light yield (LY).⁽¹¹⁾ Therefore, Eu:CaAl₂O₄ is also a promising candidate for scintillators.

In this study, Eu:CaAl₂O₄ bulk crystals with various Eu concentrations were synthesized by the floating zone (FZ) method and characterized to exhibit photoluminescence (PL) and scintillation properties. Although CaAl₂O₄ is composed of light elements and may not be ideal as general scintillators for X- or γ -ray detections, it can be used for particle detectors such as Ce:YAG and Ag:ZnS.⁽²³⁾

2. Materials and Methods

Eu-doped CaAl₂O₄ crystals were synthesized using an FZ furnace (FZD0192, Canon Machinery). First, Eu₂O₃ (99.99%), CaO (99.99%), and Al₂O₃ (99.99%) powders were mixed with a molar ratio of Eu₂O₃:CaO:Al₂O₃ = $x/2:100 - x:100$ ($x = 1, 2, 3,$ and 5). Then, the homogeneously mixed powder was formed into a cylinder rod by applying hydrostatic pressure to the mixture powder loaded in a cylindrical balloon. Next, the rod was sintered at 1250 °C for 6 h in air to obtain a polycrystalline rod. The sintered rod was loaded into the FZ furnace, and crystal growth was induced at a rotation rate of 20 rpm and a pull-down rate of 5 mm/h. Here, the heating source of the FZ furnace was a halogen lamp. To identify the obtained crystalline phases, the powder X-ray diffraction (XRD) pattern was measured using a diffractometer (MiniFlex600, Rigaku) over the 2θ range of 5–90°. The X-ray source is a conventional X-ray tube with a CuK α target operated at 40 kV and 15 mA.

The PL quantum yield (QY) as well as PL excitation (PLE) and PL contour plots were measured using a Quantaaurus-QY (Hamamatsu Photonics, C11347-01). The PLE spectrum was obtained using a spectrofluorometer (FP8600, JASCO). The PL decay time profile was evaluated using a Quantaaurus- τ (Hamamatsu Photonics, C11367), where the monitoring wavelengths were 440 and 610 nm. As scintillation properties, the X-ray-induced RL spectrum was measured utilizing our original setup.⁽²⁴⁾ The X-ray generator (Spellman, XRB80P&N200X4550) was equipped with an ordinary X-ray tube having a tungsten anode target and a beryllium window. The X-ray tube was operated with a bias voltage of 40 kV and a tube current of 5.2 mA. The emitted RL photons were guided to a spectrometer (Andor DU-420-BU2 CCD with a Shamrock SR163 monochromator) through an optical fiber of 2 m length. The detector was cooled to 188 K by using a Peltier module to reduce the thermal noise. Furthermore, the RL decay time and afterglow profiles were measured using an afterglow characterization system equipped with a pulsed X-ray tube.⁽²⁵⁾ The sensitivity of the photomultiplier tube (PMT) used is in the measurement range from 160 to 650 nm. For both PL and RL decay time profiles, the decay time constant (τ) was deduced by least-squares fitting with an exponential decay function. For pulse height spectrum measurements, a sample was mounted on the window of the PMT (Hamamatsu Photonics, R7600-200) with silicon grease

(OKEN, 6262A), and the sample was covered with several layers of Teflon reflectors to guide the RL photons to the PMT. The RL photons were converted to an electrical signal, which was then processed using a preamplifier (ORTEC, 113), a shaping amplifier (ORTEC, 570), and a multichannel analyzer (Amptek, Pocket MCA 8000A). The pulse height spectrum was eventually stored in a computer. Here, the shaping times were 2 μ s for Eu:CaAl₂O₄ samples and 0.5 μ s for the reference Ce:Gd₂SiO₅ sample.

Figure 1 shows photographs of the synthesized Eu:CaAl₂O₄ crystals. The samples look colorless and translucent. The typical size was 4–5 mm ϕ \times 10–20 mm. Under ultraviolet light (254 nm), a bright blue emission was seen by the naked eyes. The crystalline rods were cut into small pieces to characterize the luminescence properties of the crystals.

Figure 2 shows powder XRD patterns of the Eu:CaAl₂O₄ crystals and Crystallography Open Database information card (COD-2002888) for comparison. The reference XRD patterns are in agreement with the XRD patterns of all the samples, which demonstrate diffraction peaks of a CaAl₂O₄ single phase. The XRD patterns showed that the obtained materials belong to the *P* 1 2₁/*n* 1 space group of the monoclinic crystal system, and no impurity phases can be observed.

Figure 3(a) shows the PLE-PL contour plot of the 5.0% Eu:CaAl₂O₄ crystal. In spite of Eu concentrations, all the samples exhibit a PL emission with a broad band around 440 nm as well as sharp signals around 570–700 nm. The broad emission is due to the 5d–4f transitions of Eu²⁺, while the sharp signals are due to the 4f–4f transitions of Eu³⁺ (⁵D₀ \rightarrow ⁷F_{*J*}, *J* = 0–4). Here, the spectral shape of the broad emission is affected by the absorption peak at 460 nm due to Eu³⁺ (⁷F₀ \rightarrow ⁵D₂)⁽²⁶⁾ as shown in Fig. 3(b). The internal PL QYs of the 1.0, 2.0, 3.0, and 5.0% Eu-doped samples are 6.8, 13.7, 19.0, and 18.4%, respectively. Among the synthesized samples, the 3.0% Eu-doped crystal sample exhibits the highest QY; however, the value is lower than that of a Eu:SrAl₂O₄ crystal (~50%⁽¹¹⁾).

As presented in Fig. 4, the PL decay time profiles are monitored at 440 nm. The decay curve is well approximated using a single exponential decay function, and the obtained decay time constants are about 160–180 ns. From the obtained decay time constants, the fast component is due to the 5d–4f transitions of Eu²⁺.⁽²⁷⁾ Figure 5 shows the decay time profiles monitored at

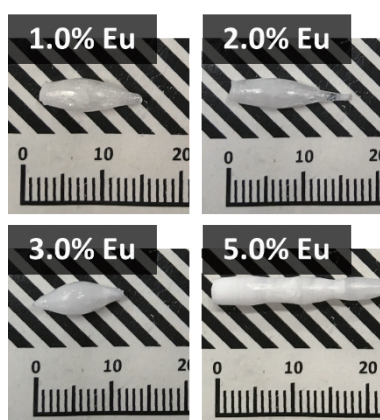


Fig. 1. (Color online) Photographs of Eu:CaAl₂O₄ crystals.

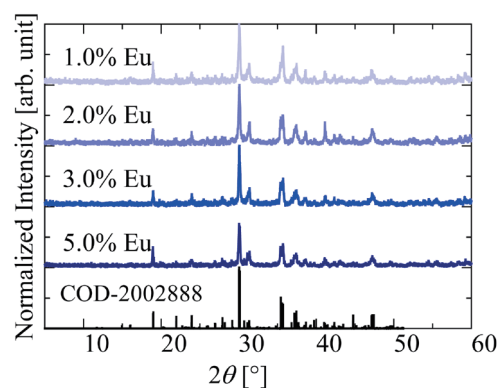


Fig. 2. (Color online) Powder XRD patterns of synthesized Eu:CaAl₂O₄.

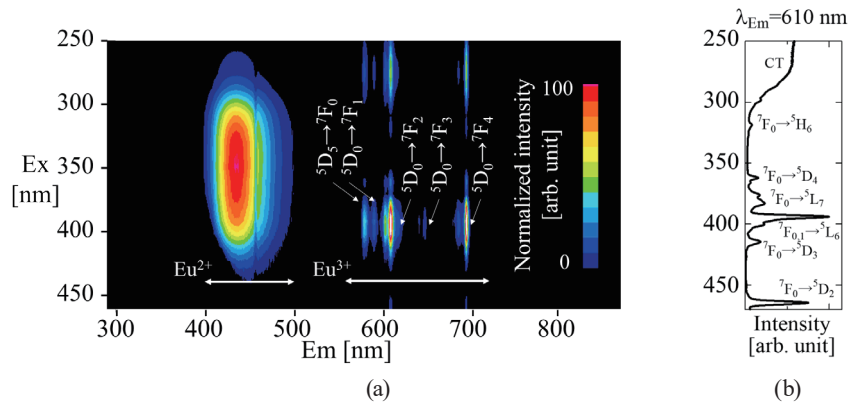


Fig. 3. (Color online) (a) Representative PLE-PL contour plot of a 5.0% Eu:CaAl₂O₄ crystal and (b) a PLE spectrum monitored at 610 nm.

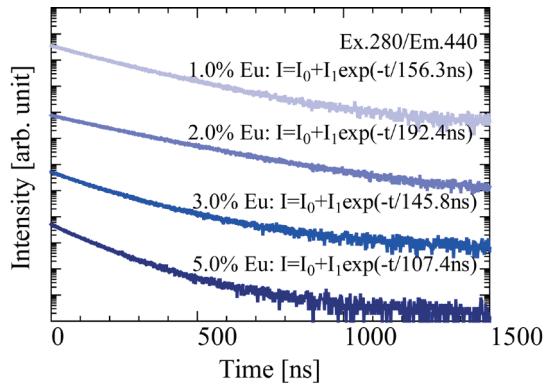


Fig. 4. (Color online) PL decay curves of Eu:CaAl₂O₄ crystals with different Eu concentrations. The PL decay signals were monitored at 440 nm at an excitation wavelength of 280 nm.

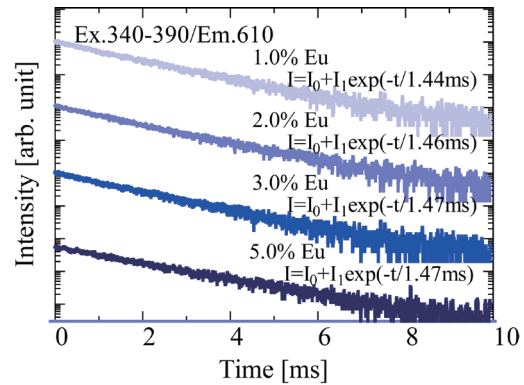


Fig. 5. (Color online) PL decay curves of Eu:CaAl₂O₄ crystals with different Eu concentrations. PL decay signals were monitored at 610 nm at an excitation wavelength of 340–390 nm.

610 nm. The decay time curves are also composed of an exponential function, where the decay time constants are close to the typical decay time constant of the 4f–4f transitions of Eu³⁺ (28,29).

Figure 6 shows the X-ray-induced RL spectra. The Eu:CaAl₂O₄ crystals show RL predominantly with a broad emission band peaking around 440 nm as well as weak peaks around 600 nm. Also, in the case of in PL, the broad emission is attributed to the 5d–4f transitions of Eu²⁺, while the weak peaks seem to be due to the 4f–4f transitions of Eu³⁺ (⁵D₀→⁷F_J, J = 0–4). The inset table in Fig. 6 shows the ratio of integral values of Eu³⁺ and Eu²⁺ emissions. As the Eu concentrations increases, the Eu³⁺ emission peaks around 600 nm as well as absorption signals at 460 nm appear to increase. Although the sample sizes are not exactly the same, it seems that the 3.0% Eu-doped sample shows the highest RL intensity of the broad emission among the samples. Figure 7 shows the X-ray-induced RL decay time profiles measured in the nanosecond range. The curves were approximated using a sum of two exponential decay functions. The decay time constants of fast components are 30–40 ns, while those of slow components, which account for ~90%, are 100–200 ns. Suggested from the decay

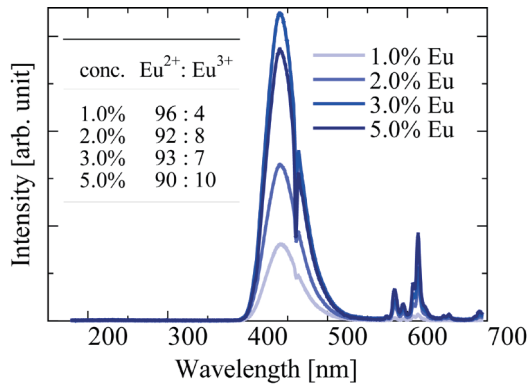


Fig. 6. (Color online) X-ray-induced RL spectra. The inset table shows the ratio of integral values of Eu³⁺ and Eu²⁺ emissions.

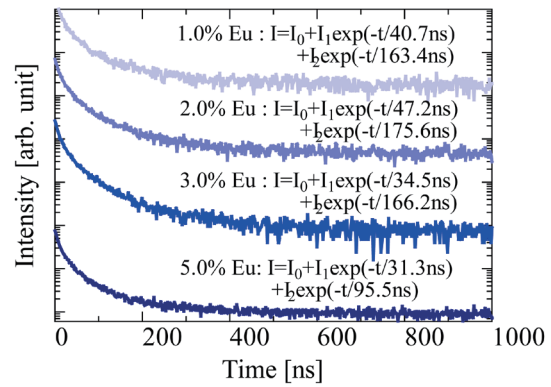


Fig. 7. (Color online) X-ray-induced RL decay curves. The wavelength sensitivity of the PMT ranges from 160 to 650 nm.

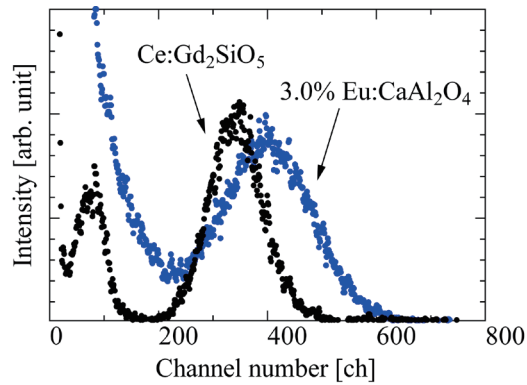


Fig. 8. (Color online) Pulse height spectra measured using 3.0% Eu:CaAl₂O₄ crystal and Ce:GSO under ²⁴¹Am γ -ray exposure.

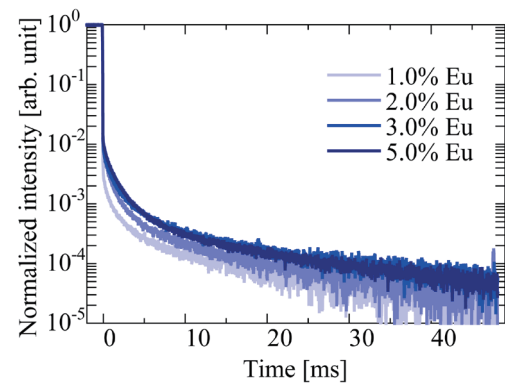


Fig. 9. (Color online) Afterglow curves of Eu:CaAl₂O₄ crystals after 2 ms X-ray exposure.

time constants, the origins are some lattice defects in the host and the 5d–4f transitions of Eu²⁺, respectively. The decay time constants of the Eu²⁺ emission are similar to those of PL and smaller than those of Eu:SrAl₂O₄ crystals.⁽¹¹⁾

Figure 8 shows the pulse height spectrum measured using the 3.0% Eu:CaAl₂O₄ crystal under ²⁴¹Am gamma-ray (59.5 keV) exposure. The pulse height spectrum was also measured using a Ce:GSO single crystalline scintillator as a reference, which has a broad emission peaking around 430 nm and a scintillation LY of 10000 photons/MeV.⁽³⁰⁾ The 3.0% Eu-doped sample exhibits a clear photoabsorption peak, while the rest do not. From the photoabsorption peak channel, the scintillation LY of the sample is 12000 photons/MeV with a typical error of $\pm 10\%$. Although the LY of the Eu:CaAl₂O₄ crystal is lower than those of Eu:SrAl₂O₄ crystals⁽¹¹⁾ as well as the famous scintillators consisting of light elements such as Ce:YAG, the emission wavelengths are more suitable for common PMTs with high quantum efficiency in the blue region.⁽³¹⁾

The afterglow curves of the synthesized samples after 2 ms X-ray exposure are shown in Fig. 9. In the analyses of the curves, the afterglow level (A) is defined as $A = 100 \times (I_2 - I_{BG}) / (I_1 - I_{BG})$.

Here, I_{BG} , I_1 , and I_2 denote the mean signal intensity before X-ray exposure, the mean signal intensity during X-ray exposure, and the signal intensity at $t = 20$ ms after X-ray irradiation, respectively. The calculated afterglow levels are 74 (1.0%), 99 (2.0%), 163 (3.0%), and 150 ppm (5.0%). The obtained afterglow levels of the Eu:CaAl₂O₄ crystals are ten times as high as those of practical scintillators (~10 ppm).⁽²⁵⁾ Among the present samples, the 1.0% Eu-doped crystal shows the lowest afterglow level.

3. Conclusions

Eu-doped CaAl₂O₄ crystals were synthesized by the FZ method. The obtained crystals exhibit PL and RL with a broad emission band around 440 nm due to the 5d–4f transitions of Eu²⁺ as well as several sharp peaks due to the 4f–4f transitions of Eu³⁺. The decay time constants are the typical values of each origin. From pulse height spectra under ²⁴¹Am γ -ray (59.5 keV) exposure, the LY of the 3.0% Eu-doped CaAl₂O₄ crystal is estimated to be approximately 12000 photons/MeV. The Eu-doped CaAl₂O₄ crystals can be a new scintillation candidate showing a blue emission suitable for sensitivity wavelengths of common PMTs. However, Eu-doped CaAl₂O₄ crystals have relatively high afterglow signals, which are unacceptable in integrated applications. To expand the scope of application, further study is required.

Acknowledgments

This work was supported by Grants-in-Aid for Scientific Research A (17H01375), Scientific Research B (18H03468), Early-Career Scientists (18K14158), JSPS Research Fellow (17J09488) from Japan Society for the Promotion of Science (JSPS), and A-STEP from Japan Science and Technology Agency (JST). The Cooperative Research Project of Research Institute of Electronics, Shizuoka University, KRF Foundation, Terumo Foundation for Life Sciences and Arts, Izumi Science and Technology Foundation, The Iwatani Naoji Foundation, The Kazuchika Okura Memorial Foundation, and NAIST Foundation are also acknowledged.

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